EXHIBIT A

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(54) METHOD FOR STORING MULTIPLE LEVELS OF DESIGN DATA IN A COMMON DATABASE

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(56) References Cited

U.S. PATENT DOCUMENTS

5,187,668	A *	2/1993	Okude et al. 716/8
5,212,650	A 1	5/1993	Hooper et al. 716/18
5,313,615	A ¹	5/1994	Newman et al 716/11
5,432,707	A ¹	7/1995	Leung 716/2
5,452,226	Α 1	9/1995	Hooper et al 716/18
5,487,018	۸ ۱	1/1996	Loos et al
5,519,627	A '	5/1996	Mahmood et al 716/18
5,541,849	A '	7/1996	Rostoker et al 716/18
5,623,417	Α '	4/1997	Iwasaki et al 716/18
5,666,288	Α '	9/1997	Jones et al 716/17
5,696,693	A 1	12/1997	Aubel et al 716/8
5,699,265	Α '	12/1997	Scepanovic et al
5,726,902	A 1	3/1998	Mahmood et al 716/6
5,727,187	A ٩	3/1998	Lemche et al 716/18
5,757,657	A	5/1998	Hathaway et al 710/9
5,761,664	Α	6/1998	Sayah et al. 707/100
5,764,534	٨	6/1998	Goetting 716/11
5,818,729	Α '	10/1998	Wang et al. 716/9
5,841,663	A ٩	11/1998	Sharma et al 716/18
5,864,487	A '	1/1999	Merryman et al. 716/6

5,956,497 A * 9/1999 Ratzel et al

(List continued on next page.)

OTHER PUBLICATIONS

Dutt ("Generic component library characterization for high level synthesis", Proceedings of the Fourth CSI/IEEE International Symposium on VLSI Design, 1991, Jan. 4, 1991, pp. 5-10).*

Dion, J. and Monier, I. M; "Countour: A Title-based Gridless Router," WRL Research Report 3/95, Digital Western Research Laboratory.

Dion, J and Monier, L.M; "Recursive Layout Generation," WRI. Research Report 2/95, Digital Western Research Laboratory

Hwang, J, et al, "Generating layouts for self-emplementing modules"; Intl Workshop on Field Programmable Logic and Applications, FPGAS, GB, Abingdon, Aug. 31, 1998, pp. 525-529

Singhal, A, et al., "Object oriented data modeling for VI.SI/CAD," Proc. of the 8th Intl Conf. on VI.SI Design, New Delhi, India, Jan. 4-7, 1995, pp. 25-29.

Feanha, H.S.; "Data astructures for physical representation of VLSI," Software Eng'g Journal, GB, IEE London, vol 5, No. 6, Nov. 1, 1990

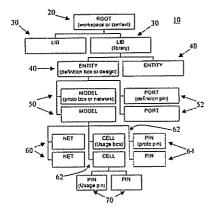
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(57) ABSTRACT

An automated logic circuit design system uses a common database to store design data at different states of the design process, including data-flow graphs, netlists and layout descriptions. In this way, the need to translate circuit descriptions between tools is eliminated, thus leading to increased speed, flexibility and integration. The common database includes entities, models, cells, pins, busses and nets. The data-flow graphs are stored as graphs, the nodes in a graph as cells, and the edges as busses. Physical design data is available by storing the cells in a model in a KD tree. This allows queries on cells in the netlist located in the layout within arbitrary areas.

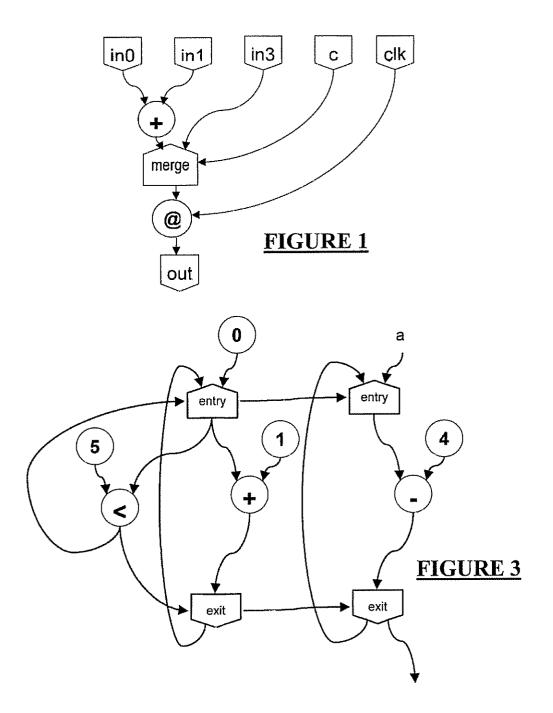
17 Claims, 4 Drawing Sheets



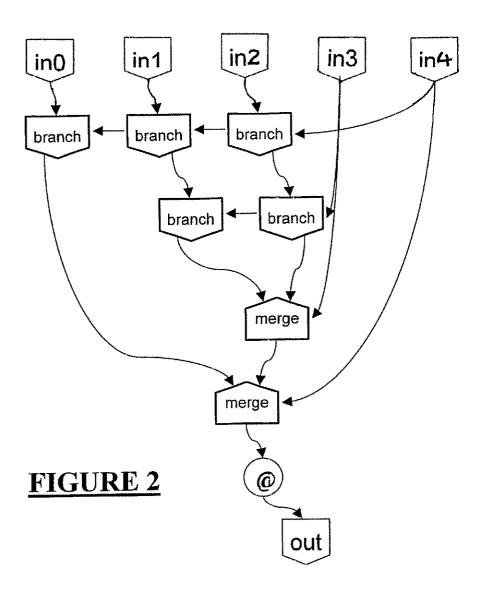
US 6,505,328 B1 Page 2

U.S. PATENT	DOCUMENTS	6,216,258 B1 * 4/2001	Mohan et al
		6,263,483 B1 * 7/2001	Dupenloup 716/18
5,960,184 A * 9/1999	Cleereman et al	6.289 489 B1 * 9/2001	Bold et al 716/1
6,026,228 A * 2/2000	Imai et al 716/188	-,,	Gan et al. 716/8
6,080,201 A * 6/2000	Hojat et al 703/14	0,500,500 131 10/2001	Gill Ct all Washington
6,145,117 A * 11/2000	Eng 716/18		
6,154,874 A * 11/2000	Scepanovic et al. 716/13	cited by examiner	

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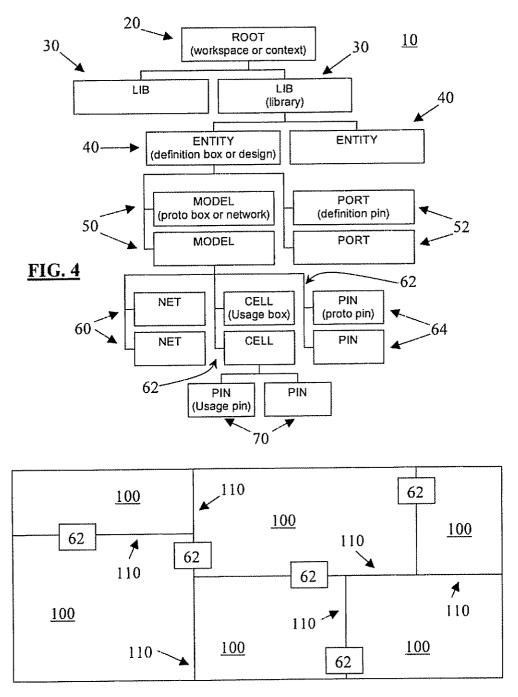
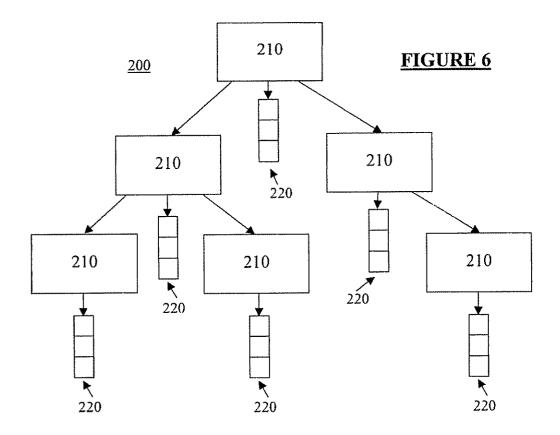


FIGURE 5

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METHOD FOR STORING MULTIPLE LEVELS OF DESIGN DATA IN A COMMON DATABASE

BACKGROUND OF THE INVENTION

1 Field of the Invention

The present invention is directed to digital logic design systems More particularly, the invention is directed to automated digital logic synthesis and placement systems.

2. Background of the Related Art

Prior art computer aided design (CAD) systems for the design of integrated circuits and the like assist in the design thereof by providing a user with a set of software tools running on a computer In the prior art, the process of designing an integrated circuit on a typical CAD system was done in several discrete steps using different software tools.

First, a schematic diagram of the integrated circuit is entered interactively to produce a digital representation of 20 the integrated circuit elements and their interconnections This representation may initially be in a hardware description language such as Verilog and then translated into a register transfer level (RTL) description in terms of predesigned functional blocks, such as memories and registers This may take the form of a data structure called a net list

Next, a logic compiler receives the net list and, using a component database, puts all of the information necessary for layout, verification and simulation into object files whose formats are optimized specifically for those functions

Afterwards, a logic verifier checks the schematic for design errors, such as multiple outputs connected together, overloaded signal paths, etc., and generates error indications if any such design problems exist In many cases, the IC physical item within one or more cells. In this case, these errors are flagged to the IC designer so that the layout cells may be fixed so that the layout cells perform their proper logical operation Also, the verification process checks the hand-laid-out cells to determine if a plurality of design rules 40 have been observed. Design rules are provided to integrated circuit designers to ensure that a part can be manufactured with greater yield. Most design rules include hundreds of parameters and, for example, include pitch between metal lines, spacing between diffusion regions in the substrate, 45 sizes of conductive regions to ensure proper contacting without electrical short circuiting, minimum widths of conductive regions, pad sizes, and the like. If a design rule violation is identified, this violation is flagged to the IC designer so that the IC designer can properly correct the cells 50 so that the cells are in accordance with the design rules

Then, using a simulator the user of the CAD system prepares a list of vectors representing real input values to be applied to the simulation model of the integrated circuit This representation is translated into a form which is best 55 suited to simulation This representation of the integrated circuit is then operated upon by the simulator which produces numerical outputs analogous to the response of a real circuit with the same inputs applied By viewing the simulation results, the user may then determine if the represented 60 circuit will perform correctly when it is constructed. If not, he or she may re-edit the schematic of the integrated circuit, re-compile and re-simulate. This process is performed iteratively until the user is satisfied that the design of the integrated circuit is correct

Then, the human IC designer presents as input to a logic synthesis tool a cell library and a behavioral model. The

behavioral circuit model is typically a file in memory which looks very similar to a computer program The behavioral circuit model contains instructions which define logically the operation of the integrated circuit. The logic synthesis tool receives as input the instructions from the RTL circuit model (i.e., Verilog or VHDL) and the library cells from the library The synthesis tool maps the instructions from the behavioral circuit model to one or more logic cells from the library to transform the behavioral circuit model to a gate schematic net list of interconnected cells. A gate schematic net list is a data base having interconnected logic cells which perform a logical function in accordance with the behavioral circuit model instructions. Once the gate schematic net list is formed, it is provided to a place and route tool

The place and route tool is used to access the gate schematic net list and the library cells to position the cells of the gate schematic net list in a two-dimensional format within a surface area of an integrated circuit die perimeter. The output of the place and route step is a two-dimensional physical design file which indicates the layout interconnection and two-dimensional IC physical arrangements of all gates/cells within the gate schematic net list

According to the above prior art method, a separate internal data structure is used for each tool This is because the tools are rarely if ever written by the same group; thus, the internal database representation for each tools is likely to differ from that of the other tools. Also, the most appropriate database implementation for the integrated circuit depends on the phase of the design process in which it is being used For example, linked lists are commonly used to store cells in a netlist because that is the most obvious solution for logic synthesis purposes. In contrast, a KD tree is a more appropriate database format for the place and route tool

This is time-consuming and processor-intensive (circuit designer improperly connected or improperly placed a 35 specifications must be translated from one database format to another and another during the development process), disk-intensive (multiple databases each specifying the same circuit in different forms must be stored) and fragmented (tools cannot use the outputs of other tools, and a change to the circuit made by one tool is not reflected in the databases of the other tools)

SUMMARY OF THE INVENTION

The present invention has been made with the above problems of the prior art in mind, and a first object of the present invention is to provide a system for automated logic circuit design which is capable of storing and utilizing multiple levels of design data in a common database

Another object of the present invention is to provide a system for automated logic circuit design which eliminates the need for translation of circuit descriptions between different design tools

A further object of the present invention is to provide a system for automated logic circuit design which allows the output of tools in the design suite to be used by other tools

Yet another object of the present invention is to provide a system for automated logic circuit design which allows design tools or the user to make area queries, i.e., a selection of a subset of objects based on their physical position, at various stages in the design process.

A still further object of the present invention is to provide a system for automated logic circuit design which permits the use of global simulation tools such as timing engines across all levels of design abstraction

Another object of the present invention is to provide a system for automated logic circuit design which presents a unified model for timing, synthesis, placement and routing

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A further object of the present invention is to provide a system for automated logic circuit design which has high storage and run-time efficiency

A still further object of the present invention is to provide a system for automated logic circuit design which has a 5 consistent and easy to use programming interface

A still further object of the present invention is to provide a system for automated logic circuit design which has an interface which is not dependent on other include files.

A further object of the present invention is to provide a system for automated logic circuit design which uses an object-oriented C++ programming style

The above objects are achieved according to an aspect of the invention by providing an automated logic circuit design system which uses a common database to store design data at different states of the design process, including data-flow graphs, netlists and layout descriptions. In this way, the need to translate circuit descriptions between tools is eliminated, thus leading to increased speed, flexibility and integration. The common database includes entities, models, cells, pins, busses and nets. The data-flow graphs are stored as graphs, the nodes in a graph as cells, and the edges as busses. Physical design data is available by storing the cells in a model in a KD tree. This allows queries on cells in the netlist located in the layout within arbitrary areas.

BRIEF DESCRIPTION OF THE DRAWINGS

These and other objects, features, and advantages of the present invention are better understood by reading the following detailed description of the preferred embodiment, taken in conjunction with the accompanying drawings, in which:

FIGS. 1-3 are dataflow diagrams of a circuit structure according to a preferred embodiment of the present invention:

FIG. 4 is a block diagram of the structure of a data model according to the present invention; and

FIGS. 5 and 6 are diagrams of the partitioning of a chip 40 in correspondence with the data model.

DETAILED DESCRIPTION OF THE PRESENTLY PREFERRED EXEMPLARY EMBODIMENT

First, given a Verilog description of a circuit to be developed, the Verilog must be parsed to generate a data flow graph suitable for implementation in the data model. RTL parsers known in the art are preferably used for this purpose. The output from the RTL parser is a Verilog parse tree which is used to generate the data flow graph Although well-known in the art, the structure of the parse tree is relatively complicated and, since detailed knowledge of it is not necessary for an understanding of the present invention, further description of the parse tree will be omitted for simplicity and brevity

FIG. 1 shows an example of translation of the Verilog source code

always @(posedge clk)
begin
out=in1+in2;
if (c)
out=in3;

into data flow elements. Here, in0, in1, in2, c and clk are input ports of an Entity (described below) and out is an

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output port of the Entity An adder (an example of a Ceil as described bellow) adds the values at Ports in0 and in1 and supplies the result to a merge block (another example of a Ceil). If the value at Port c represents a logical true, the merge block supplies the value at Port in2 to a delay block (again, a Ceil); if the value at Port c represents a logical false, the merge block supplies the output of the adder to the delay block. On the positive-going edge of the signal at Port clk, the delay block provides the value on its input to the output port out. The data flow graph having been generated, it may then be stored in the data model.

Before describing the data model in more detail, a few more examples are in order FIG 2 shows an example of the data graph resulting from the Verilog code

if (c1) begin
out=in0;
end else begin
if (c2) begin
out=in1
end else begin
out=in2
end

Here, if the value at input Port c1 is a logical true, the branch module connected to input Port in0 is enabled and provides its output to a merge module which is also enabled when c1 is true. If c1 is not true, the branch modules connected to Ports in1 and in2 are enabled to provide their outputs to other branch modules. One of the modules in this second tier is enabled when the value at input Port c2 is true and provides its output to another merge block. The other of the modules in the second tier is enabled when c2 is false and provides its output to the other merge block. Depending on the value of c2, one of those outputs is provided to the first merge block, and depending on the value of c1, one of the output is provided to the output port out via the delay element.

Finally, repetitive structures such as for, while and forever loops can be implemented in the data flow graph FIG. 3 shows an example of the data flow graph implementation of the Verilog code

integer i; for (i=0; i<5; i++) begin a=a-4 end

Here, an entry node initializes a loop index with the value 0, adds 1 to the index and checks to see if the index is less than 5. If so, an exit node loops back for another pass. In tandem with this loop, an input variable a is received through another entry node and 4 is subtracted from it on each pass through the loop. When looping ceases because the index has reached 5, the current value of the input variable is presented at the exit node.

Certain optimizations can be performed on the data flow graph. For example, in the above loop structure the loop can be unrolled That is, the graph portion representing the body of the loop can be replicated five times and the graph portion representing the loop index can be eliminated. For timing estimations and the like, virtual loop unrolling can be performed by estimating the number of iterations through the loop and using that number as a multiplier in delay calculations; the actual circuit replications can be done later

Once the Verilog source is converted to a data flow graph, it can be implemented in the data model Preferably, the data model is implemented using the C++ programming language

or a similar object-oriented language. Since the construction, accessing and destruction of objects in such languages is well-known in the art, examples of specific commands for performing these operations will be omitted for brevity.

The topmost object in the data model 10 (shown in FIG 4) is the Root object 20 The Root object 20 owns all other objects 30-70 and serves as a base to which everything else is attached Also, the root 20 accommodates global attributes which are shared by all objects 20-70.

At the next level of the data model 10 is the Library object 30 Library objects 30 are used to organize entities 40. The preferred embodiment of the present invention includes at least two Libraries 30. The first stores information on the technology library to which the circuit under development will be mapped, and the second stores information on the

Next is the Entity object 40 An Entity 40 defines the interface of a design; that is, the set of ports 52 that the Entity 40 has An Entity 40 may own Port objects 52 A Port 52 is used to represent the pin-out of an entity 40 Ports 52 cannot be individually created and destroyed, and can only be 20 created when an Entity 40 is created Each Port 52 has a direction (in, out, in/out) which is determined upon creation of the Entity 40. This rigidity promotes consistency between the Entity 40, its Models 50 and the Cells 62 bound to those Models 50.

As noted above, Entities 40 own Models 50 A Model 50 defines an implementation of an Entity 40; thus, multiple Models 50 within an Entity 40 represent different implementations of that Entity 40. Generally, these Models 50 are functionally identical to one another. For example, an Entity 30 40 in a technology Library 30 may have several Models 50 defining various eight bit adder cells having different power levels Similarly, an Entity 40 in a target Library 30 may have several Models 50 which respectively define an abstract logic representation of a circuit, a gate-level imple- 35 mentation of it, a uniquefied representation, etc. The contents of each Model 50 is a net list of Nets 60, Cells 62 and Model Pins 64. All Models 50 and the Entity 40 have the same number of Pins 64 and Ports 52, and the Ports 52 have the same direction in the Entity 40 and over all Models 50; thus, it is relatively easy to replace one Model 50 with another from the same Entity 40

Below the Models 50 are Cell objects 62 A Cell 62 represents a section of logic. Cells 62 may be primitive cells or non-primitive cells Primitive Cells 62 have a predefined 45 functionality associated with them Preferably, the primitive Cells 62 include the following types:

CELL_AND-unlimited fan-in AND gate;

CELL_XOR-unlimited fan-in OR gate;

CELL_TRI-tri-state buffer

CELL_REG-sequential element

CELL_DC-don't care set

CELL_BREAK-break point cell; used to implement a "don't touch"; and

CELL_ONE-a constant one; an inverted or bubbled version is used for a constant zero.

In contrast to primitive Cells, the functionality of nonprimitive Cells is defined by technology Models 50 to which they are bound. That is, a Cell 62 may describe a portion of 60 the circuit under development and belong to a Model 50 in a target Library 30. However, it will be associated with (preferably by pointing through a cell type attribute or the like) a Model 50 in a technology library 30 which defines its functionality and general characteristics

Non-primitive Cells 62 may be created as bound Cells; alternatively, they may be created as unbound Cells and later

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bound to a Model 50. This may be done by specifying the Cell's name; by specifying pin-to-pin correspondence vectors; and by binding the Cell 62 to an undefined Model 50 and later matching the Model 50 to an actual one Additionally, a bound Cell 62 can be rebound to a different Model 50 within the same Entity 40

Each Cell 62 includes a number of parameters called members which specify certain features of the Cell 62 These include the cell's name, a pointer to the technology Model 50 to which it is bound, a list of Pins 64 which it owns, its parent Entity 40, and coordinates of the Cell 62 within the chip layout

Net objects 60 make connections between pins. The pins may be Model pins 64 or Cell pins 70. A Net 60 does not own Pins 64 and 70, and deleting the Net 60 will leave the pins 64 and 70 disconnected. Pins 64 and 70 may be grouped into Busses 80 (in fact, every variable in the Verilog code will be represented as a Bus) Since Pins 64 and 70 are the most common object in almost any circuit representation, it is important to reduce the amount of storage for each Pin 64 and 70 as much as possible while maintaining easy accessibility. For this reason, Pins 64 and 70 are preferably stored in small arrays and associated with indices.

Nets 60 also have members, such as the Net's name, a list 25 of Pins 64 and 70 which it connects, and a list of rectangles through which it passes in the placement layout Pin members include the Pin's name, the Model 50 or Cell 62 to which it belongs, and the Net 60 to which it is connected

Each object 20-70 may have a number of attributes. Each attribute has a name and a value of a type int, short, float, double, char* and void* One example of an object attribute is an inversion attribute or "bubble" which specifies whether a Cell input or output (or Net 60) is asserted high or low Other examples of object attributes are object name, firing information, references to the Verilog code defining the object, etc

Iterators are procedures used to access objects within the data model. As is known in the art, an iterator traverses the model and each time it is called, returns a pointer to the next object of a particular type. For example, a Model iterator would, when successively called, return pointers to each Model 50 within the data model. The preferred embodiment of the present invention provides "safe" and "unsafe" iterators, where unsafe iterators return all objects of the specified type, even if they have been added during the iteration process, and safe iterators omit objects added during the iteration. In this way, although the safe iterators are slightly slower than their unsafe counterparts, they can avoid program crashes, errors and exceptions, and other so undesirable outcomes

Before synthesis and timing can take place it is often necessary to uniquefy the data model This involves binding each Cell 62 to its own individual technology Model 50 This simplifies the synthesis process in that changes made to one technology Model 50 will affect only the Cell 62 which is bound to it, and no others Also, after uniquefication it is possible to traverse the data model both up and down, since each object has a unique parent and child Typically, uniquefication is done by making a copy of a technology Model 50 for each Cell 62 which is bound to it and associating one of the cells 62 to each copy

After the data model has been uniquefied, it may be ungrouped, i.e., macro-level cells can be replaced with their primitive components. Alternatively, processes may handle the data model with virtual ungrouping by "looking through" the macro-level cells to process their primitive cell constituents

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With this understanding of the structure of the data model in mind, implementation of a Verilog-derived data flow graph in the data model will now be described. For each module in the Verilog description there will be one Entity 40 and one Model 50 (hereinafter collectively referred to as a graph). The ports for the Entity 40 correspond to the ports in the Verilog module. Ports 52 in the graph have a bit width, and there will be a separate Pin 64 and Net 60 (the group of Nets 60 for the Port 52 forming a Bus) in the graph for each Verilog port.

For each node in the Verilog module, a Cell 62 will be made in the graph Initially the Cells 62 will be unbound. As described above, given the Cell type and the Pins 70 of the Cell 62, a Model 50 for the Cell 62 to be bound can be generated later.

Each Model 50 is preferably implemented as a KD tree as follows First, the circuit under development is divided into a number of sections each corresponding to a rectangular section 100 of the available chip area as shown in FIG 5 The partitioning of the circuit can be directed by the user; 20 however, it is preferably automatically done by the system so that the circuit is evenly distributed over the entire chip area. Each node or leaf 210 of the KD tree 200 shown in FIG. 6 corresponds to a cutline 110 of the rectangles 100 and may have appended thereto a linked list 220 of all cells 62 25 which lie on that cutline 110 Non-leaf nodes 210 in the KD tree 200 each have two child nodes 210, with the left child 210 corresponding to the region of the chip on one side of the cutline 110 and the right child 210 corresponding to the region of the chip on the other side of the cutline 110. 30 Similarly, the child nodes 210 may have linked lists 220 of cells on their cutlines 110 and child nodes 210 of their own

It should be noted that the leaf nodes 210 will contain most of the circuit information, since the non-leaf nodes 210 will only have information on those cells touching their 35 corresponding cutline.

As noted above, the initial distribution of Cells 62 over the chip area is preferably done automatically by the system and in that case may be done through the use of various algorithms which will readily suggest themselves to those 40 skilled in the art. The result of this process is a model with mostly logical information on its constituent elements but with a coarse framework of physical placement and routing information, e.g., cell areas, initial placements, etc. In later steps of the development process described below, the 45 physical information will be refined and augmented within the original data model. In this way, the addition of rough physical layout information to the initial logical description enables the smooth transition of the circuit through the development process, thereby enabling sharing of tool 50 outputs, use of common diagnostics and the like.

Further, once RTL synthesis is complete and the data model is flattened, it may be copied and used as a baseline for formal verification and the like Since a common model structure is used, there is no need to translate the pre-logic 55 synthesis version of the circuit into a format suitable for use by the verification tool

As the development process progresses, the KD tree 200 may become unbalanced due to an excessive number of additions or deletions in one area, or due to poor initial 60 distribution. This can be compensated for by manual rebalancing by the user or by a user-initiated procedure, but preferably is done automatically by the system.

Once the data model has been constructed in this way, it may be used for both logic synthesis, i.e., gate-level 65 implementation, etc., and physical synthesis, i.e., placing and routing. This is because the data model includes all of

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the information necessary for logical synthesis operations, i.e., cell functionality, net connections, etc., as well as all information necessary for physical synthesis operations, i.e., areas, physical positions, etc

Another advantage of the data model arises from its correspondence with the actual physical chip layout. Since each node of the KD tree 200 corresponds to a cutline 110 and has associated with it the cells on the cutline and information on where its child nodes are within the chip area, portions of the circuit in specific physical areas can be queried, tested and manipulated without the need to read the entire data model into active memory from disk storage, as is the case with prior art net lists For example, assuming a user wanted to work with only the lower right hand corner of the chip, the system could traverse the KD tree to reach the topmost node corresponding to that area. Then, that node, its children, netlists and the like would be read into active memory from disk and manipulated. The user may even be able to manually direct placement of cutlines 110 at certain points to frame a particular area of interest. The system may then adjust the KD tree accordingly to accommodate the new arrangement. This area query technique is possible whether the circuit is in its final placement and routing stages or fresh from Verilog synthesis

Although only a portion of the entire data model need be read into memory, the complete set of Nets 60 is typically maintained in memory This is because the Nets 60 are necessary for purposes such as delay estimation and the like that are performed frequently, and it is easier to retain all Nets 60 in memory rather than repeatedly read them into memory Thus, once a specific area has been designated for querying, the Nets 60 corresponding to that area must be identified. This is done by identifying the Nets 60 connected to each of the Pins 64, 70 within the selected area. The remaining Nets 60 can be eliminated from consideration during the area query. Nets 60 which have some, but not all, Pins 64, 70 within the query area can have the missing pins represented by a stub pin. Finally, Nets 60 which have all of their pins within the query area can be handled as are other objects within the selected area

Further, during the area query process, Nets 60 which are entirely contained within the selected area can be optimized out or otherwise modified; however those nets having portions outside the query area, i.e., those with stub pins, cannot, since the effect of modification of elimination of these Nets 60 on the remaining circuit portions is unpredictable.

Further, since the logical and physical aspects of the circuit are integrated into a single data model from the start, deviations from the classic logical synthesis/physical synthesis partition can be made. For example, the inclusion of buffers for load handling and timing purposes is normally done as part of the logical synthesis process; however, using a common data model for all aspects of the development process allows the placement of buffers to be delayed until later during the placement process, when layout information is more definite and precise. The above description of the preferred embodiment of the present invention has been given for purposes of illustration only, and variations thereof will be readily apparent to those skilled in the art. For example, although Verilog has been used as the preferred language for initial input of the circuit under development, other appropriate hardware description languages may of course be used Also, although implementation of the data model using object-oriented C++ techniques has been disclosed, other programming languages and paradigms may also be workable Similarly, alternative object hierarchies

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may be used. Such variations fall within the scope of the present invention. Thus, the scope of the present invention should be limited only by the appended claims.

What is claimed is:

- 1. A common data model representing a circuit that will 5 be fabricated on an integrated circuit chip comprising:
 - a data representation including a plurality of objects that together represent the circuit, certain ones of the objects including a netlist portion that represents a corresponding portion of the circuit, and each of the objects: being logically correlated to at least one other object so that all of the objects describe the circuit; and each of the objects, once associated with a physical location is adapted for subsequent retrieval using an area query corresponding to the physical location
- 2 The model according to claim 1 wherein the physical location association of objects is implemented using hierarchical partitioning
- 3. The model according to claim 2 wherein the bierarchical partitioning is implemented using a tree.
- 4. The model according to claim 3 wherein the circuit is represented within an area, with a plurality of cuttines that partition the area into a plurality of rectagles
- 5. The model according to claim 4 wherein the tree contains a plurality of leaf nodes, and each of the leaf nodes 25 corresponds to one of the cutlines
- 6. The model according to claim 5 wherein the tree includes a linked list that identifies each cell that lies on a particular one of the cutlines
- 7 The model according to claim 5 wherein the tree ³⁰ contains a plurality of non-leaf nodes, each of the non-leaf nodes associated with one of the leaf nodes, and each of the non-leaf nodes, containing at least two child nodes, each

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child node corresponding to an area on an opposite side of the cutline associated with the one leaf node

- 8 The model according to claim 3 wherein certain of the objects represent cells.
- 9 The model according to claim 3 wherein certain of the objects represent a net or a part of a net
- 10. The model according to claim 3 wherein certain of the objects represent pins.
- 11. The model according to claim 1 wherein the each of the objects corresponding to each of the physical locations is maintained in an active memory
- 12. The model according to claim 11 wherein the subsequent retrieval of objects corresponding to the physical location of the area query causes the retrieval of all objects associated with the physical location to be retrieved into an active memory.
- 13. The model according to claim 12 wherein the retrieval of all objects associated with the physical location is from a disk storage.
- 14. The model according to claim 1 wherein the model allows for insertion of cutlines to frame a particular area of interest.
- 15. The model according to claim 1 wherein the area query takes place either immediately after synthesis or during final placement and routing.
 - 16 The model according to claim 1 wherein the model is configured to allow for a logical query to take place
- 17 The model according to claim 16 wherein the logical query of one object provides at least another object that is logically related to the one object

* * * * *

EXHIBIT B



(12) United States Patent Srinivas et al.

US 6,519,745 B1 (10) Patent No.: Feb. 11, 2003 (45) Date of Patent:

(54) SYSTEM AND METHOD FOR ESTIMATING CAPACITANCE OF WIRES BASED ON **CONGESTION INFORMATION**

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(22) Filed: May 26, 2000

G06F 9/45; H03K 19/173; (51) Int. Cl.⁷ H03K 19/177; G01R 31/26

....... 716/5; 326/38; 326/39; U.S. Cl. 438/17; 716/2; 716/11; 716/13; 716/6

Field of Search 702/81; 716/1-21; 257/277; 326/36, 39; 327/99; 438/17

(56)References Cited

U.S. PATENT DOCUMENTS

6,185,722	B 1	٠	2/2001	Darden et al 71	6/5
6,311,139	B1	•	10/2001	Kuroda et al 702	/81
6,327,693	B1	٠	12/2001	Cheng et al 71	6/2

* cited by examiner

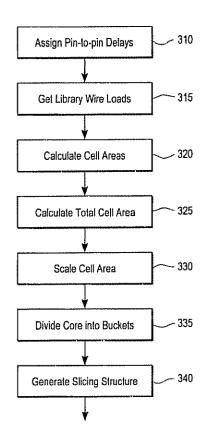
Primary Examiner-Vuthe Sick Assistant Examiner-Helen Rossoshek

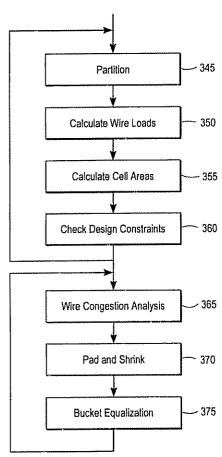
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ABSTRACT

A system for calculating interconnect wire lateral capacitances in an automated integrated circuit design system subdivides the chip area of a circuit design to be placed and routed into a coarse grid of buckets. An estimate of congestion in each bucket is computed from an estimated amount of routing space available in the bucket and estimated consumption of routing resources by a global router This congestion score is then used to determine the spacing of the wires in the bucket which is in turn used to estimate the capacitance of the wire segment in the bucket.

8 Claims, 7 Drawing Sheets





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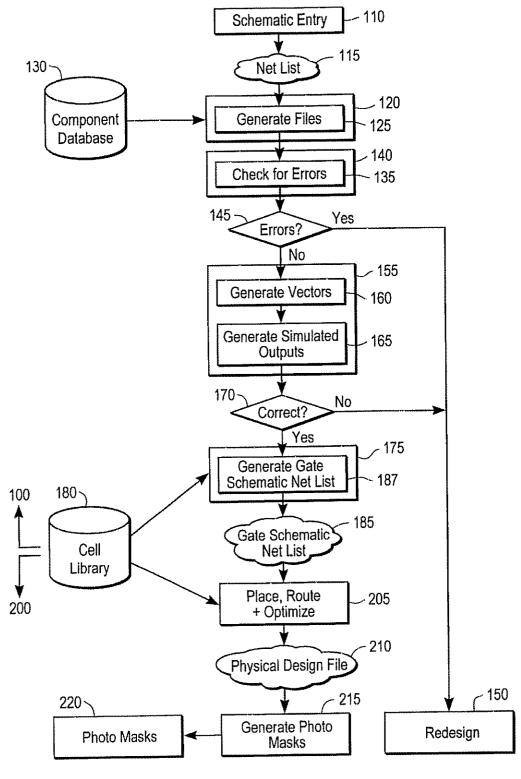


FIG. 1

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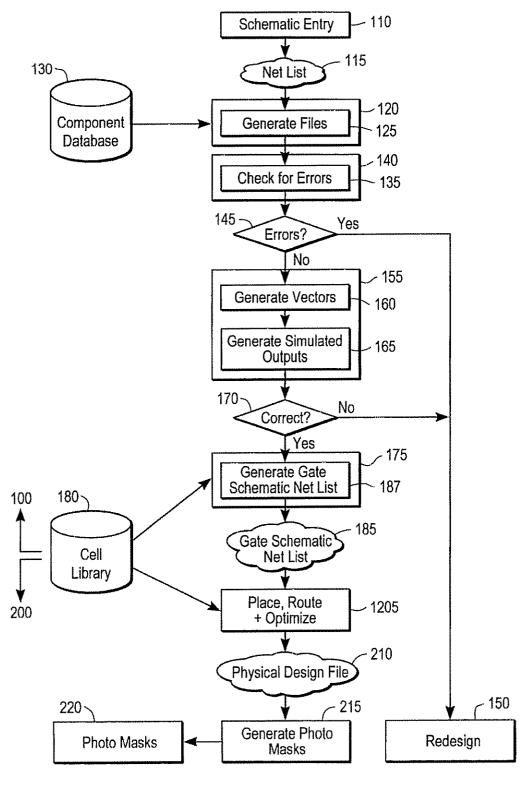


FIG. 2

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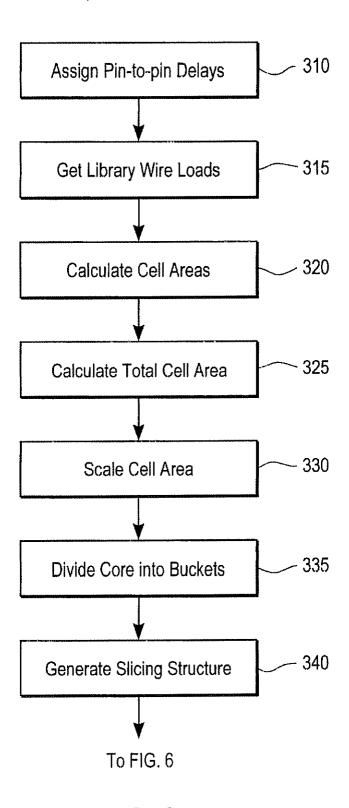


FIG. 3

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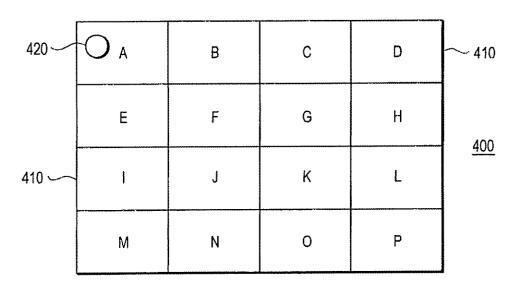
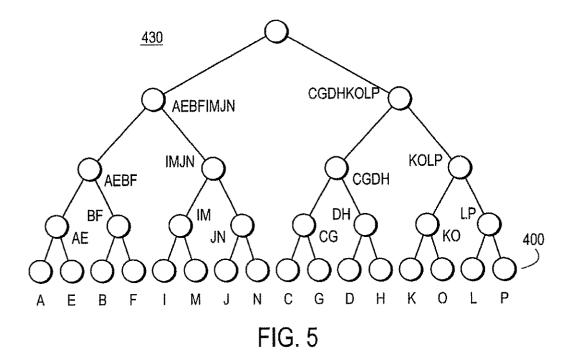


FIG. 4



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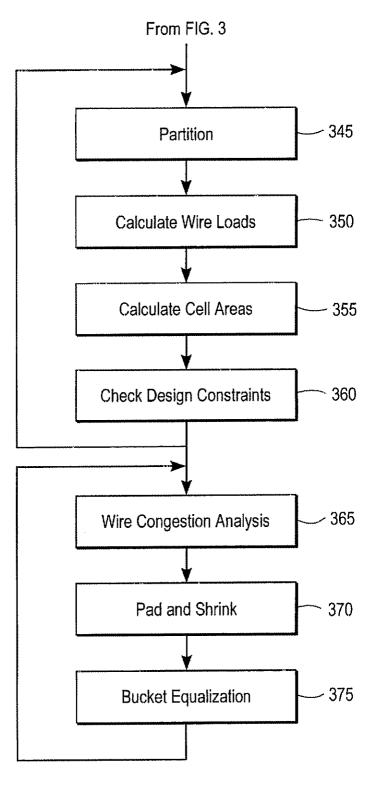


FIG. 6

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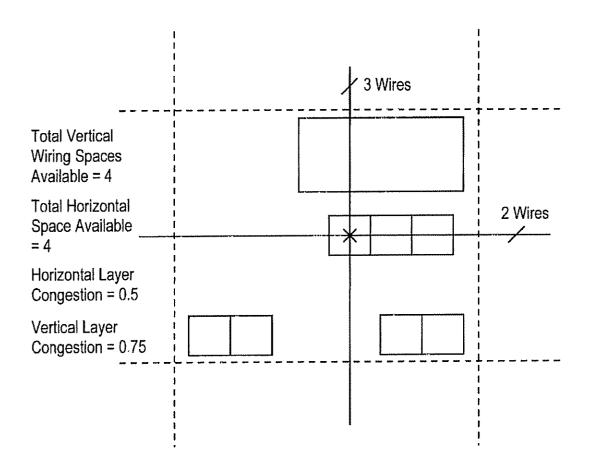
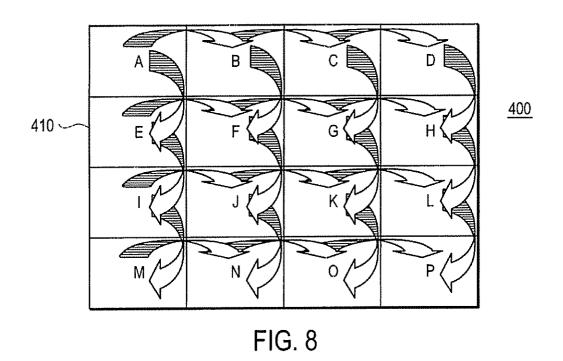


FIG. 7

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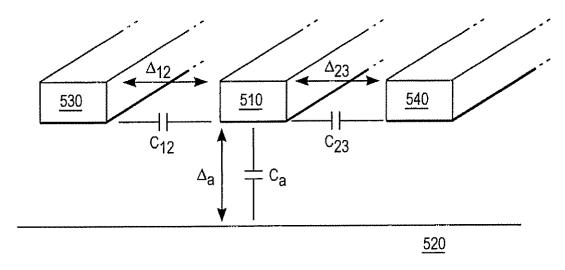


FIG. 9

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SYSTEM AND METHOD FOR ESTIMATING CAPACITANCE OF WIRES BASED ON **CONGESTION INFORMATION**

BACKGROUND OF THE INVENTION

1. Field of the Invention

The present invention is directed to digital logic design systems. More particularly, the invention is directed to automated digital logic synthesis and placement systems for integrated circuits, and to performance optimization of digital integrated circuits

2. Background of the Related Art

Prior art computer aided design (CAD) systems for the 15 design of integrated circuits (ICs) and the like assist in the design thereof by providing a user with a set of software tools running on a digital computer In the prior art, the process of designing an integrated circuit on a typical CAD system is done in several discrete steps using different 20

The design process can be broadly divided into two phases. The initial phase 100 (shown in FIG. 1) of selecting the right components and connecting them so that the desired functionality is achieved is called logical synthesis. The second phase 200, in which the selected components are placed within the confines of the chip boundaries and the connecting wires are laid out in order to generate the photographic masks for manufacturing, is called physical synthesis

First, in the logical synthesis phase 100 a schematic diagram of the integrated circuit is entered interactively in Step 110 to produce a digital representation 115 of the integrated circuit elements and their interconnections. This representation 115 may initially be in a hardware description language such as Verilog or VHDL and then translated into a register transfer level (RTL) description in terms of predesigned functional blocks, such as memories and registers. This may take the form of a data structure called a net list

Next, a logic compiler 120 receives the net list in Step 125 and, using a component database 130, puts all of the information necessary for layout, verification and simulation into object files whose formats are optimized specifically for those functions

Afterwards, in Step 135 a logic verifier 140 preferably checks the schematic for design errors, such as multiple outputs connected together, overloaded signal paths, etc., and generates error indications in Step 145 if any such design problems exist In many cases, the IC designer 50 improperly connected or improperly placed a physical item within one or more cells. In this case, these errors are flagged to enable her to correct the layout cells in Step 150 so that they perform their proper logical operation

Also, in Step 135 the verification process preferably 55 checks the cells laid out by hand to determine if multiple design rules have been observed. Design rules may include the timing requirements of the circuit, the area occupied by the final design and parameters derived from other rules dictated by the underlying manufacturing technology These 60 phase affects the propagation delay through the wires design rules are provided to integrated circuit designers to ensure that a part can be manufactured with a high degree of yield Most design rules include hundreds of parameters and, for example, include pitch between metal lines, spacing between diffusion regions in the substrate, sizes of conduc- 65 tive regions to ensure proper contacting without electrical short circuiting, minimum widths of conductive regions, pad

sizes, and the like. If a design rules violation is identified in Step 150, this violation is preferably flagged to the IC designer so that she can properly correct the cells so that they are in accordance with the design rules in Step 150

Then, using a simulator 155 the user of the CAD system may prepare a list of vectors representing real input values to be applied to a simulation model of the integrated circuit in Step 160. This representation may be translated into a form which is better suited to simulation. This representation of the integrated circuit is then operated upon by the simulator which produces numerical outputs analogous to the response of a real circuit with the same inputs applied in Step 165 By viewing the simulation results, the user may then determine in Step 170 if the represented circuit will perform correctly when it is constructed. If not, she may re-edit the schematic of the integrated circuit, re-compile it and re-simulate it in Step 150. This process is performed iteratively until the user is satisfied that the design of the integrated circuit is correct.

Then, the human IC designer may present as input to a logic synthesis tool 175 a cell library 180 and a behavioral circuit model. The behavioral circuit model is typically a file in memory which looks very similar to a computer program, and the model contains instructions which logically define the operation of the integrated circuit. The logic synthesis tool 175 maps the instructions from the behavioral circuit model to one or more logic cells from the library 180 to transform the behavioral circuit model to a gate schematic net list 185 of interconnected cells in Step 187. The gate schematic net list 185 is a database having interconnected logic cells which perform a logical function in accordance with the behavioral circuit model instructions. Once the gate schematic net list 185 is formed, it is provided to a place and route tool 205 to begin the second phase of the design process, physical synthesis

The place and route tool 205 is preferably then used to access the gate schematic net list 185 and the library cells 180 to position the cells of the gate schematic net list 185 in a two-dimensional format within a surface area of an integrated circuit die perimeter The output of the place and route step may be a two-dimensional physical design file 210 which indicates the layout interconnection and twodimensional IC physical arrangements of all gates/cells within the gate schematic net list 185 From this, in Step 215 the design automation software can create a set of photographic masks 220 to be used in the manufacture of the IC.

One common goal in chip design involves timing performance. The timing performance of the chip is determined by the time required for signals to propagate from one register to another. Clock signals driven at a certain frequency control storage of data in the registers. The time required for a signal to propagate from one register to another depends on the number of levels of cells through which the signal has to propagate, the delay through each of the cells and the delay through the wires connecting these cells. The logic synthesis phase 100 influences the number of levels and the propagation delay through each cell because in it the appropriate components are selected, while the physical synthesis 200

During the process of timing optimization during physical design in Step 205, circuit timing is evaluated based on an initial placement and selection of cell strengths. The feedback from the timing analysis is used to drive repeated improvements to the placement software and the selection of the strengths of the cells. The automation software may also perform buffering on some parts of the circuit to optimize

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the timing performance by inserting repeater cells, i.e., buffers, to speed up certain paths Preferably, the optimization software tentatively applies one such modification, evaluates the timing and other constraints (such as design rules dictating capacitance limits) to determine if the step is 5 acceptable and then makes the change permanent if it is deemed acceptable

The interconnection of the cells in the placing and routing of Step 205 generally involves interconnect wiring having between two and seven metal layers. The delay through an 10 interconnect wire depends on the capacitance of the wire, its resistance and, to a lesser extent, the inductance of the wires. The capacitance of a wire 510 (see FIG 9) consists mainly of the capacitance Ca due to the overlap of the wire with the and the capacitance due to the overlap along the side walls with other signal wires 530 and 540 adjacent to it, called the lateral capacitance C_L=C₁₂+C₁₃ The capacitance of a given wire such as wire 510 can be calculated on a case-by-case basis as is known in the art, and will primarily depend on the $^{-20}$ wire dimensions D_W and D_T as well as the distance D_L of the wire 510 from the other layers 520 and the distance D $_{12}$ and D_{23} of the wire 510 from the other wires 530 and 540 In deep sub-micron manufacturing technologies the widths of the wires are becoming thinner and thinner, making them tall 25 and narrow. As a result, under current development trends the lateral capacitance C_L is becoming a dominant component of the total wire capacitance

During the process of timing optimization during physical design, circuit timing is evaluated based on an initial placement and selection of cell strengths. The feedback from the timing analysis is used to drive the repeated improvements to the placement software and the selection of the strengths of the cells. Since physically laying out all the wires without violating design rules and maintaining good delays is a very time consuming step, a Steiner tree-based topology is used to estimate the area and delay due to the wires based on the current cell placement.

An Elmore delay model is commonly used to compute the 40 wire delay based on the Steiner tree-based topology However, computing the capacitance of the wires based on the Steiner tree topology is difficult, because nothing is known about the spacing of the wires and the adjacency of different signals at this point in design Existing approaches 45 use the worst case scenario, and assume that there are wires adjacent to the signal wire in consideration and thus tend to over-estimate the capacitance. Since the optimization software depends on the feedback from the timing analysis, accurate estimation of the capacitance is crucial to the 50 success of the optimizations

SUMMARY OF THE INVENTION

In view of the above problems of the prior art, it is an object of the present invention to provide a method of 55 estimating the effect of adjacent wires on the capacitance of a signal wire in a circuit design which provides estimates superior to prior art techniques

It is another object of the present invention to provide a method of estimating the effect of adjacent wires on the 60 delay g, in turn, is defined by capacitance of a signal wire in a circuit design which provides estimates for better than worst case scenarios

One of the indicators for the expected spacing of the wires in the final routed circuit is the density of the interconnect wires at a given point, i.e., the wires' congestion. The greater 65 the number of wires that passes through a given bucket, the greater the density of wires in that bucket will be and as a

result the spacing tends to be smaller to fit all the wires. It would be advantageous to make use of the congestion in a circuit to derive an early estimate of the capacitance

Thus, it is yet another object of the present invention to provide a method of estimating the effect of adjacent wires on the capacitance of a signal wire in a circuit design which provides estimates based on an estimate of congestion in the design

The above objects are achieved according to an aspect of the invention by subdividing the chip area of a circuit design to be placed and routed into a coarse grid of buckets. An estimate of congestion in each bucket is computed from an estimated amount of routing space available in the bucket layer 520 above or below, called the area capacitance C_n, 15 and estimated consumption of routing resources by a global router. This congestion score is then used to determine the spacing of the wires in the bucket which is in turn used to estimate the capacitance of the wire segment in the bucket

BRIEF DESCRIPTION OF THE DRAWINGS

These and other objects, features and advantages of the present invention are better understood by reading the following detailed description of the preferred embodiment, taken in conjunction with the accompanying drawings, in which:

FIG 1 is a flowchart of an integrated circuit design process according to the prior art;

FIG 2 is a flowchart of an integrated circuit design process according to a preferred embodiment of the present invention;

FIGS. 3 and 6 are a flowchart showing a place and route process according to the preferred embodiment;

FIG 4 shows a coarse grid with buckets in a circuit used with the preferred embodiment;

FIG 5 shows a slicing structure used in the preferred embodiment;

FIG. 7 shows a cell upon which congestion calculations are performed according to the preferred embodiment;

FIG. 8 shows a bucket mincut process according to the preferred embodiment; and

FIG 9 shows the major components in routing wire capacitance

DETAILED DESCRIPTION OF PRESENTLY PREFERRED EXEMPLARY EMBODIMENTS

In one model, the delay through a single logic gate can be represented as

$$d-g h+p \tag{1}$$

where d is the delay, g is a parameter called the "logical effort" of the gate, h is a parameter called the "electrical effort" of the gate, and p is the parasitic or fixed part of the

$$g_{gate} = \frac{R_{\text{gate_min}} C_{\text{Gate_min}}}{R_{\text{line_min}} C_{\text{line_min}}}$$
(2)

where gate_min refers to a minimum-sized gate and inv_ min to a minimum-sized inverter h, in turn, is defined by

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$$h = \frac{c_{\text{put}}}{c_{\text{in}}} \tag{3}$$

where cont is the capacitance out of the gate and cin is the capacitance into the gate

In a constant delay approach to cell placement, the pin-to-pin delay of each cell is fixed early on in the optimization flow. This delay is maintained independently of the load a cell drives. In order to keep delay constant, the size of the cell is adjusted according to the load that it drives. As a result, the area of each cell in the design varies with the load that it drives. The area of each cell is

$$a=b+s c_{out}$$
 (4)

where b and s are constants related to the logic of the cell and the chosen constant delay for the cell Thus, the total area of the netlist is, in matrix notation for plural gates,

$$A = B + SC$$
 (5)

Approximating the input load at each pin of the cell by c_k/h_k, the total load at the output of a cell i is

$$c_i = \frac{c_j}{g_j} + \frac{c_k}{g_k} + d_i \tag{6}$$

or, alternatively,

$$c_i = \sum_{\text{fanoat}} \frac{c_4}{h_1} + d_i \tag{7}$$

of cell i is the sum of all its fanout loads plus the load of the wire connecting the cell to its fanouts. In matrix notation for plural gates,

$$C = IIC + D$$
 (8)

$$(I-H)C=D$$
 (9)

Setting G=I-H,

$$GC = D$$
 (10)

$$C=G^{-1}D \tag{11}$$

where C is the output capacitance of all gates in the circuit and D is the wire load. Thus, according to the last equation above, the output load of the cells in the circuit can be found 50 once the placement is known. Then, the size of each cell can be found to keep its delay constant. The area of each cell in the netlist denoted by A is

$$A = K_1 + K_2^T C \tag{12}$$

and substituting Equation (10) gives

$$\Lambda = K_1 + K_2^T G^{-1}D$$
 (13)

Since the load of each wire can be represented as d=u l, 60 in FIG 5. where d is the wire load, u is the load per unit length of wire and 1 is the total length of the wire,

$$A = K_1 + \mu i K_2^T G^{-1} L \tag{14}$$

and combining constant terms,

$$A = K_1 + WL \tag{15}$$

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Thus, in order to minimize the circuit area one can minimize WL, where the matrix W may be viewed as a set of weights of the wire lengths L

Generally, the cell is modeled as a rectangle, with the height of the rectangle being the height of a standard cell row. Thus, the width and therefore the area of the cell are functions of the load.

The preferred embodiment of the present invention processes a data structure representative of the circuit being 10 placed and routed Preferably, this is done on a digital computer as is known in the art. The data structure may be a netlist or other suitable structure known in the art; however, it is preferably a data model of the type disclosed in the US patent application Ser. No. 09/300,540 to Van (4) 15 Ginneken et al; however, other simpler structures may be

The overall flow of a place and route process 1205 (see FIG 2) according to a preferred embodiment of the present invention is shown in FIGS 3 and 6 Since a design constraint of the placement process is that the delay across a net be constant, in the preferred embodiment the area of a cell is dependent on the load it drives. In turn, the load of a wire is not known with certainty until the placement process is finished Thus, to make an initial placement of cells within 25 the core some initial estimations are preferably made. Each cell is assigned a pin-to-pin constant delay in Step 310. Appropriate techniques will be readily apparent to those skilled in the art; however, pin delay assignment is preferably done according to the technique described in the U.S. 30 patent application Ser. No. 09/300,666. Throughout the placement process, this delay will be maintained constant and the area of the cell varied according to the load it drives in order to achieve the assigned delay.

To make the initial cell placement, the area of each cell is where d, is the wire load. That is, the total load at the output 35 calculated in Step 320 using wire loads obtained from the cell library in Step 315 and substituted into Equation 15 Although cells of varying power levels are available only in discrete steps in the target cell library, this phase of the technique proceeds as if a continuous spectrum of cell power (8) 40 levels are available and selects a cell from the library closest to the size ultimately selected as one of the final steps of the process

The total cell area A_{total} is determined by adding up the areas of all the cells in Step 325, and the sizes of the cells (10) 45 are scaled to achieve a target percentage of core utilization in Step 330. Based on this, standard cell rows are created.

More specifically, the core 400 where the cells are placed is divided into coarse placement regions called buckets 410 as shown in FIG. 4 Each bucket 410 is a small rectangular region within the core 400 Buckets 410 have equal dimensions but the placeable area within a bucket 410 depends on the presence of blockages such as macros in the bucket 410. A bucket 410 can accommodate about fifty average-sized standard cells 420. Then, in Step 340 a slicing structure or (12) 55 binary tree 430 is built whose leaves 440 are the coarse buckets 410 For example, a core 400 having a 4x4 matrix of buckets 410 imposed thereon (of course, in practice there will be a much greater number of buckets 410) as shown in FIG. 4 can be represented by the slicing structure 430 shown

Cells 420 are assigned to the buckets 410 so that the total area of cells 420 within each bucket 410 closely matches the area of that bucket 410. This is done by an iterative bipartitioning of the data model. First, a horizontal or vertical cut of the core 400 is chosen. The total area available on each side of the partition is computed Cells 420 are divided using quadratic placement (see below) and a mincut technique

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(see, e.g., Fiduccia et al., "A Linear Time Heuristic for Improving Network Partitions", ACM/IEEE Design Automation Conference, 1982, pp. 175-81) on each side so that total wire length is minimized This iteration continues until a desired resolution, e.g., a bucket 410, is reached.

Later, each cell 420 is assigned to one of the buckets 410 using a partitioning technique in Step 345 as shown in FIG 6. The second placement is done instead of a single cell-level placement because the first placement is done with a coarse grid, i.e., buckets containing hundreds of cells. Here, the cells are placed into their corresponding buckets. In the later stage when other optimizations such as choosing the size and adding repeaters are done and the netlist is more stable, the second, detailed placement is done. This placement step places a cell in its actual location. In this stage, some cells 15 may move from their originally-assigned bucket to a neighboring bucket to make room for the cells in a highly populated bucket in order to reduce congestion.

A good placement of cells 420 is one that can be easily routed and satisfies the given timing constraints for the logic circuit. Quadratic placement, and in particular Gordian quadratic placement, finds a legal placement while minimizing the total squared wire length in the circuit and is the placement technique preferably used Gordian quadratic placement is well-known in the art as shown by, e.g., 25 Klienhans et al., "GORDIAN: VLSI Placement by Quadratic Programming and Slicing Optimization", IEEE Trans on Computer-Aided Design, v. 10, n. 3 (Mar. 1991), pp. 356–365, and for simplicity will be generally described below

The problem is independently solved for the x and y coordinates. Briefly describing the process for the x coordinates (the process for the y coordinates is similar), quadratic placement solves the following equation subject to a constraint Hx=t (to account for physical realities such as overlapping cells and the like) to minimize total wire length during placement:

$$\frac{1}{2}\left(\sum \alpha_{ij}(x_i-x_j)^2 + \sum \alpha_{ij}(x_i-b_j)^2\right) \tag{16}$$

$$\frac{1}{2}x^{2}Ax-x^{2}d+constant$$
 (17)

x is the location of cells 420 and star nets. Star nets are nets with more than fifteen pins. A star net is treated like a cell 420. All cells 420 attached to a star net are considered to be attached to the center of the net through a two-pin net. Star nets are used to reduce the number of fill-ins in the matrix. A. The weight of a net k_i is 2/(number of pins). The weight of a net connecting a cell 420 to the center of a star net is 1 b has the locations of fixed points. Fixed points are pins of pads or macros. The diagonal elements of A are non-zero and are computed as follows:

$$a_i = SUMk_i$$
 (18)

Any cell 420 connecting to cell ii through a non-star net and a star net connecting to a cell i contribute to the summation. The element a_{ij} is non-zero if cells i and j are connected 55 through a net

$$a_{ij}$$
=-SUM k_i (19)

The contribution comes from the nets connecting cells i and i

$$d_i = SUM b k_i$$
 (20)

The contribution comes from all constant pins attached to cell i The x coordinates for a placement that minimizes the total wire length is obtained by solving

$$Ax=d$$
 (21)

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The initial constraints for quadratic placement assumes the center of mass for all cells 420 on the chip is the center of the chip. If the area of each cell is a_i , $\Sigma a_i x_i = X_{center}$ forms the first constraints for quadratic placement

The place and route software then performs global routing on the placed cells 420 Global routing is a coarse level routing that uses Steiner tree-based topologies to connect the bucket centers. The use of Steiner trees in such contexts is well-known in the art; see, for example, Borah et al, "An Edge-Based Heuristic for Steiner Routing", IEEE Transactions on Circuits and Systems 1563-68 (1993) and Griffith et al, "Closing the Gap: Near-Optimal Steiner Trees in Polynomial Time", IEE Transactions on Computer-Aided Design of Integrated Circuits and Systems, v 13,n 11 (Nov. 1994) 1351-65 (both incorporated herein by reference) and will not be described in greater detail herein

When the global routing software adds a wire through a bucket (either during the initial Steiner tree calculation or during recalculations as described below), the budget for the appropriate layer is adjusted to reflect the use of one routing resource from the bucket More specifically, in order to concisely describe congestion in a bucket, the available routing space in each routing layer is estimated in advance by the computer and assigned to the bucket as a budget for that layer Every time a wire is routed through the bucket in a particular routing layer, the budget for that layer is adjusted to reflect that one routing space has been spent. The lower the number of available spaces, the greater the congestion in the bucket in the given routing layer.

FIG 7 illustrates an example of a bucket with three routing wires running through it in the vertical direction in one layer and two routing wires running through it in the horizontal direction in another layer. The congestion score for a bucket is defined as the ratio of the routing resources used so far to the total routing resources available in the bucket. For example, the vertical layer of the bucket of FIG 7 has a total of four routing spaces (its actual dimensions will be larger than this due to design rule considerations as described in greater detail below), and three vertical wires are going through the bucket. Thus, this bucket has a congestion score of 0.75 along the layer in the vertical routing direction. Similarly, the horizontal routing direction has 2 wires going through it, resulting in a congestion score of 0.5.

When the capacitance for a wire is estimated, e.g., during optimization operations such as inserting repeaters, choosing appropriate strengths, etc., the congestion score for each of the buckets the wire goes through is used to compute the spacing for the wire segment in the bucket. To calculate the congestion score for a bucket, it is important to remember that design rules require a certain amount of free space on each side of a routing wire. Thus, a layer having spaces to accommodate ten routing wires which has five routed therethrough (wire-space-wire-space) may have 100% congestion because the layer cannot accommodate any more routine wires while maintaining the separation design rule

Given the above, one can see that a layer having 50% congestion can roughly be thought of as having a number of routing wires with one empty space on one side and two empty spaces on the other—omitting the required space on each side of the wire, it has one wire for two usable spaces). A layer having 33% congestion can similarly be thought of as having routing wires with one space on one side and three spaces on the other, or with two spaces on one side and two spaces on the other (one wire in three usable spaces) A layer having 25% congestion can be thought of as having routing

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wires with two spaces on one side and three spaces on the other (one wire in four usable spaces). Further discrete points can be derived with more sparse routing layers.

Given a maximum of three spaces between adjacent wires in a routing layer, a suitable equivalence chart might be:

Congestion Score	Corresponds to
0-23%	3 spaces/3 spaces
23-29%	2 spaces/3 spaces
29-42%	2 spaces/2 spaces
	OF
	1 space/3 spaces
42-75%	1 space/2 spaces
75-100%	1 space/1 space

In a variation on the preferred embodiment the spacing value for the wires are rounded to the nearest integers and a congestion score of more than 75% is considered to have a spacing of 1 on both sides (the minimum spacing which could conform to the design rules), a congestion score of 50% represents a spacing of 1 on one side and 2 on the other side and a score below 50% uses spacing of 2 on both sides.

Hence if the initial number of routable spaces available in a bucket is 10 and we have routed three wires through it then the congestion score for the bucket is 30%. Each wire running through this bucket will be assumed to have a spacing of 2 on both sides.

The interconnect wire capacitance determination makes use of the spacing thus computed to compute the lateral capacitance for the wire segment As is known in the art, this can be done by taking a number of parameters of the technology into account; for example, design rule spacings, distance of the routing layer from the substrate, thickness and material of the wires and the like Generally speaking, the most important factors are the width and spacing of the wires

The capacitance of the whole net is then computed by adding up the contribution of each wire segment belonging to the net. It may then be used where needed in optimization operations, e.g., inserting repeaters, choosing appropriate strengths, etc.

Based on the routed cell arrangement resulting from the initial Steiner tree arrangement, the cell areas can be recalculated in Step 355 using Equation 15 with the new wire loads substituted therein At this point, the cell placement will likely be somewhat unbalanced This imbalance may take several forms:

widely varying cell utilization percentages—for example, if the core utilization before the cell area recalculation is 90%, after recalculation some buckets 410 will have higher utilization percentages and some buckets 410 will have lower utilization percentages. This is undesirable because, for example, overutilized buckets 410 may present obstacles to wire routing or usage of pads.

cell recalculation enlarges the size of some cells 420 so that they do not fit within their buckets 410, or so that they overlap other cells 420

cell recalculation results in too much wasted area, i.e., 60 unutilized core area.

To correct these problems, an iterative procedure is used. First, the current layout is checked to see if it meets given utilization constraints such as core utilization percentage in Step 360 If so, the placement procedure is complete and this 65 part of the routine ends. If not, i.e., if the total area A_{rotal} of the cells 420 does not fit in the core 400 within the given

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predetermined utilization constraints, the procedure returns to Step 345 where repartitioning is conducted by coarse placement based on the last-determined cell areas from Step 350, and the repartition-recalculation-checking loop is iteratively executed again based on the newly-calculated cell areas and wire loads to further converge toward an acceptable placement.

Additional analysis shows that it is always possible to find a floorplan where the total area of the cells 420 matches the core area. Consider a coarse placement where each cell 420 has a location (xi, yi) and an area based on the load it drives as outlined above. From Equation 14 above, the total area of the design is

$$A_{C\pi ll} = K_1 + WL \tag{22}$$

Now, assume both x and y directions are stretched by a factor of α The length of each wire is increased by α , and since the cell area is linearly dependent on the wire length,

$$A_{Scalad Cell} = \alpha(K_1 + WL)$$
 (23)

However, by scaling the core 400 by a factor of a its area will increase quadratically:

$$A_{Scaled Core} = \alpha^2 A_{Core}$$
 (24)

Since the core area increases more rapidly that the cell area as they are scaled, at some point the core area will be equal to and then exceed the cell area. This point can be found by setting the scaled core area equal to the total scaled 30 cell area and solving for α:

$$\alpha^2 A_{Co:\tau} \sim \alpha(K_1 + WL) \tag{25}$$

$$\alpha = \frac{B + WL}{A_{Corr}} \tag{26}$$

This is the factor by which the core 400 must be enlarged to accommodate the total cell area

After a satisfactory placement has been found in Step 560,
the cell area in individual buckets 410 is balanced to balance
routing resource usage and area usage among all buckets
410 First, a global router assigns routes to all nets in Step
365 and an analysis of routing resources on the core 400
determines congested areas. In Step 370, cells 420 in the
most congested areas are "padded" by arbitrarily increasing
their areas slightly, and cells 420 in the most underutilized
areas are "shrunk" by arbitrarily reducing their areas
slightly This tends to increase the rate at which cells 420
migrate from overutilized areas to underutilized areas.

Next, a bucket equalization process is applied to the cells 420 to move cells 420 from overutilized buckets 410 to underutilized ones in Step 375 This is a sort of "bucket brigade" movement in which a cell 420 moves at most from one bucket 410 to an adjacent bucket 410. For example, in 55 a series of ten consecutively numbered buckets 410 on a horizontal path, if cells 420 need to be moved from bucket I to bucket 10, some cells 420 are moved from bucket 1 to bucket 2; some from bucket 2 to bucket 3, etc. As cells 420 move from one bucket 410 to another, the loads of nets attached to them change. This causes a corresponding change in the area of other cells 420 in the design, and these are corrected locally rather than through a global recalculation process. To ensure that changes to cell areas are minimized, cell movements along many different paths are examined and only the best used.

Finally, in the pairwise refinement process of Step 380, a mincut process is applied between adjacent buckets 410 in

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a sweeping fashion as shown in FIG 8 Starting from the topmost corner of core 400, each bucket 410 and its immediate neighbors to the right and bottom are repartitioned in order to reduce the number of crossing nets. One full pass of the repartitioning ends when the bottom rightmost bucket 5 410 is reached. At this point, the total wire length in the circuit is computed in Step 385 and the areas of all cells 420 are readjusted in Step 390. If there is an improvement in wire length, another iteration through the process is begun at Step 365; if not, this part of the process is complete.

After the strengths of the cells 420 are optimized based on the timing analysis using the global routing topologies, track routing is performed which assigns a specific routing space in the bucket 410 to each wire. The final stage of physical routing software puts the physical wires following the space 15 assignment made by the track routing as closely as possible and completes the connections for all the cells

The present invention has been described above in connection with a preferred embodiment thereof; however, this has been done for purposes of illustration only, and the 20 invention is not so limited Indeed, variations of the invention will be readily apparent to those skilled in the art and also fall within the scope of the invention

For example, the embodiment has been described in connection with a discrete integer spacing architecture; 25 however, the invention is not so limited and may be used with fractional or other non-integer systems as well Further, although in the preferred embodiment a maximum spacing of three was used, higher-order spacings may be used as well.

What is claimed is:

1 A method of estimating capacitance of interconnect wires in an integrated circuit chip design, the method comprising: 12

grouping a plurality of cells in the design into a plurality of buckets;

maintaining a congestion score for each bucket;

when routing a wire through a bucket, modifying the congestion score accordingly; and

using the congestion score to calculate an estimated capacitance for the wire

- 2. The method of claim 1, wherein the congestion score is a ratio of a number of available wire routing spaces in a given layer of the bucket in a given direction to a total number of wire routing spaces in the given layer of the bucket in the given direction
 - 3 The method of claim 1, wherein maintaining the congestion score for each bucket includes excluding a wire routing space required to be empty in order to meet design rules from consideration as an available wire routing space.
 - 4 The method of claim 1, wherein using the congestion score to calculate an estimated capacitance for the wire includes estimating a spacing on at least one side of wires in a bucket based on that bucket's congestion score
 - 5 The method of claim 4, wherein using the congestion score to calculate an estimated capacitance for the wire includes estimating a spacing on both sides of wires in the bucket based on that bucket's congestion score.
 - 6 The method of claim 4, wherein a range of congestion scores is equivalent to a given spacing configuration for wires in the bucket.
- 7 The method of claim 1, wherein using the congestion score to calculate an estimated capacitance for the wire includes adding together a plurality of estimated capaci-30 tances for segments of the wire in different buckets.
 - 8 The method of claim 1, wherein the calculated estimated capacitance includes a lateral capacitance component

* * * *

EXHIBIT C

(12) United States Patent Buch et al.

(10) Patent No.: US 6,931,610 B1 (45) Date of Patent: Aug. 16, 2005

(54) METHOD FOR RAPID ESTIMATION OF WIRE DELAYS AND CAPACITANCES BASED ON PLACEMENT OF CELLS

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- (*) Notice: Subject to any disclaimer, the term of this
- patent is extended or adjusted under 35
 U.S.C. 154(b) by 0 days

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(52)	U.S. Cl.	G06F 17/50 716/5; 716/13; 716/14 earch 716/5, 13, 14

(56) References Cited

US PATENT DOCUMENTS

5,461,576	Α	•	10/1995	Tsay et al.	716/6
5,784,289	Α	•	7/1998	Wang	716/8
6,151,568	Α	*	11/2000	Allen et al	703/14
6,434,731	B1	*	8/2002	Brennan et al	716/10
6,513,149	B1	*	1/2003	Donato	716/12
6,658,631	B1	*	12/2003	Pyo et al	716/4
2001/0010090	A1	*	7/2001	Boyle et al	716/2

OTHER PUBLICATIONS

NN9108421, "Method of Estimating Capacitance in RC Constraint Generation", IBM Technical Disclosure Bulletin, vol. 34, No. 3, Aug. 1991, pp. 421–423 (4 pages).*

Sivakumar et al, "The clade vertebrata: spines and routing in ad hoc networks", Proceedings of Third IEEE Symposium on Computers and Communications, Jun 30, 1998, pp. 599-605*

Das et al, "Routing in ad hoc networks using a spine", Proceedings of the Sixth International Conference on Computer Communications and Networks, Sep. 22, 1997, pp. 34–39.*

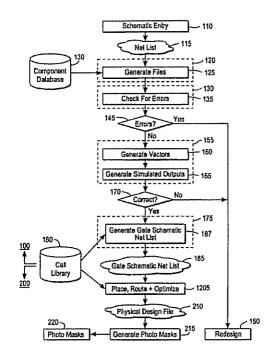
* cited by examiner

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(57) ABSTRACT

A fast method of estimating capacitances and wire delays in an integrated circuit design is based on placement information such as that contained in a gate schematic net list from a logic synthesis tool. A simple tree topology called a spine tree is constructed to connect the pins of the net as an approximation of actual connections therein. Capacitance is extracted for this topology assuming a worst case scenario, and Elmore delays are computed for the wire delays based on the worst-case capacitances. The method takes linear time as a function of the number of pins in the net and is much faster than using a Steiner tree method in this context.

10 Claims, 6 Drawing Sheets



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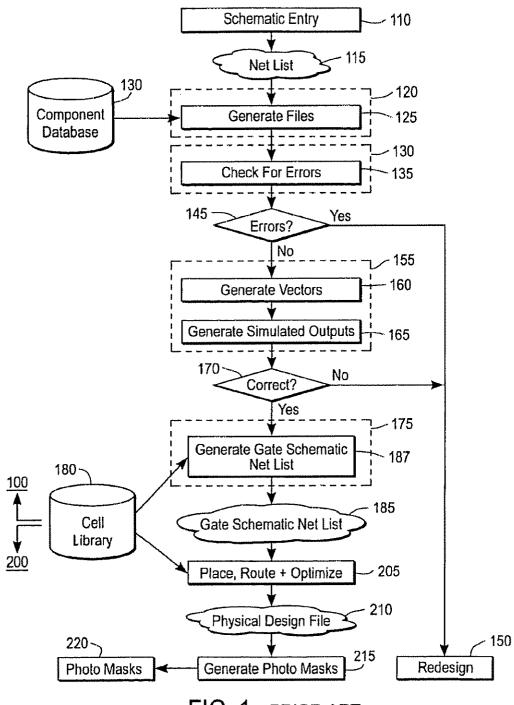
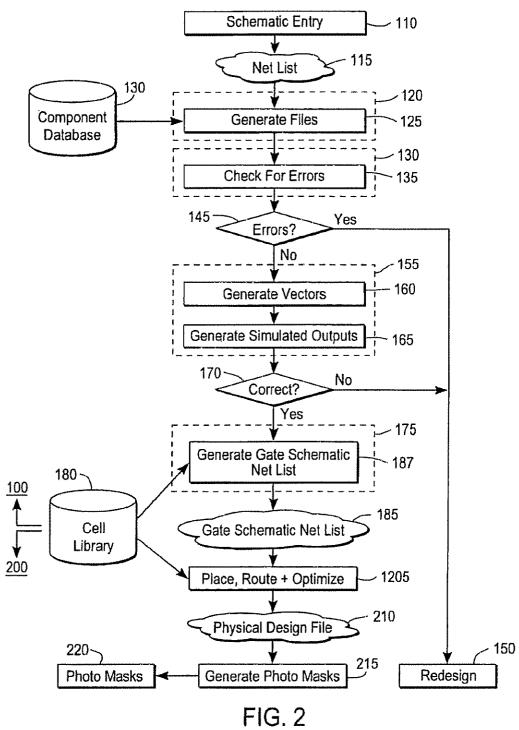


FIG. 1 PRIOR ART

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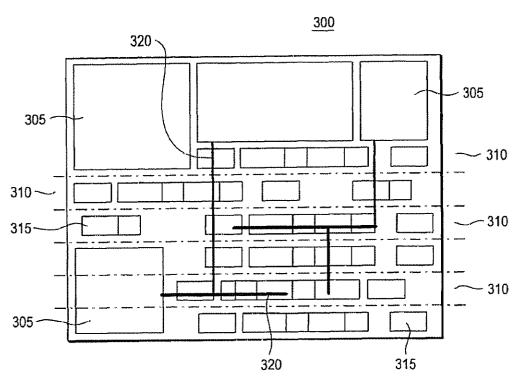
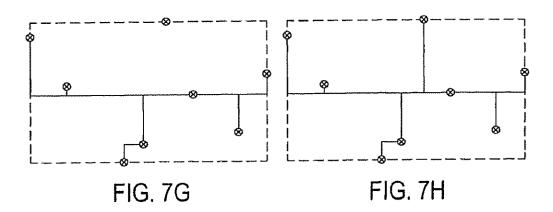


FIG. 3

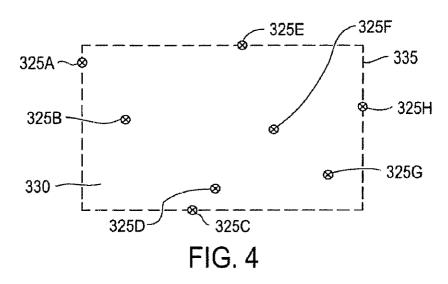


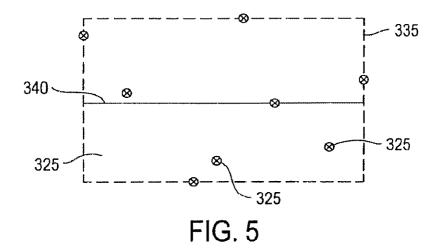
U.S. Patent

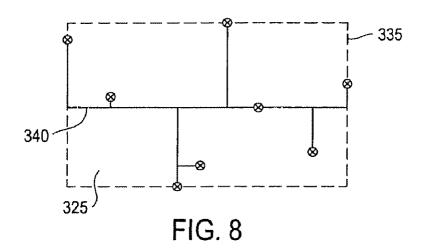
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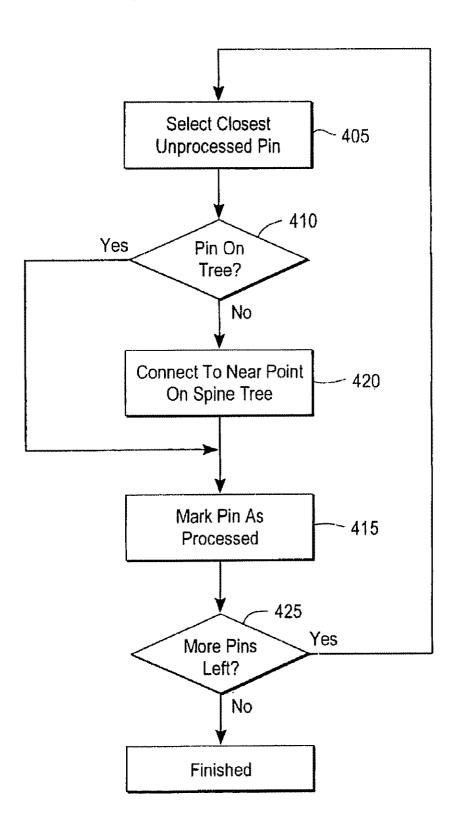


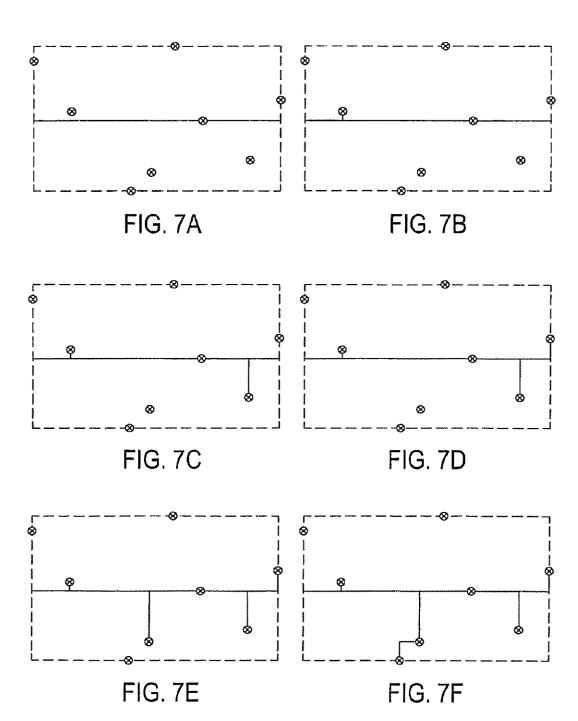
FIG. 6

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METHOD FOR RAPID ESTIMATION OF WIRE DELAYS AND CAPACITANCES BASED ON PLACEMENT OF CELLS

BACKGROUND OF THE INVENTION

1 Field of the Invention

The present invention is directed to digital logic design systems. More particularly, the invention is directed to 10 automated digital logic synthesis and placement systems for integrated circuits, and to performance optimization of digital integrated circuits

2. Background of Related Art

Prior art computer aided design (CAD) systems for the 15 design of integrated circuits (ICs) and the like assist in the design thereof by providing a user with a set of software tools running on a digital computer. In the prior art, the process of designing an integrated circuit on a typical CAD system is done in several discrete steps using different 20 software tools

The design process can be broadly divided into two phases. The initial phase 100 (shown in FIG 1) of selecting the right components and connecting them so that the desired functionality is achieved is called logic synthesis. The second phase 200, in which the selected components are placed within the confines of the chip boundaries and the connecting wires are laid out in order to generate the photographic masks for manufacturing, is called physical synthesis

First, in the logic synthesis phase 100 a schematic diagram of the integrated circuit is entered interactively in Step 110 to produce a digital representation 115 of the integrated circuit elements and their interconnections. This representation 115 may initially be in a hardware description language such as Verilog or VHDL and then translated into a register transfer level (RTL) description in terms of predesigned functional blocks, such as memories and registers This may take the form of a data structure called a net list.

Next, a logic compiler 120 receives the net list in Step 125 and, using a component database 130, puts all of the information necessary for layout, verification and simulation into object files whose formats are optimized specifically for those functions

Afterwards, in Step 135 a logic verifier 140 preferably checks the schematic for design errors, such as multiple outputs connected together, overloaded signal paths, etc., and generates error indications in Step 145 if any such improperly connected or improperly placed a physical item within one or more cells In this case, these errors are flagged to enable her to correct the layout cells in Step 150 so that they perform their proper logical operation

Also, in Step 135 the verification process preferably 55 checks the cells laid out by hand to determine if multiple design rules have been observed. Design rules may include the timing requirements of the circuit, the area occupied by the final design and parameters derived from other rules dictated by the underlying manufacturing technology These 60 design rules are provided to integrated circuit designers to ensure that a part can be manufactured with a high degree of yield Most design rules include hundreds of parameters and, for example, include pitch between metal lines, spacing between diffusion regions in the substrate, sizes of conduc- 65 tive regions to ensure proper contacting without electrical short circuiting, minimum widths of conductive regions, pad

sizes, and the like. If a design rules violation is identified in Step 150, this violation is preferably flagged to the IC designer so that she can properly correct the cells so that they are in accordance with the design rules in Step 150

Then, using a simulator 155 the user of the CAD system may prepare a list of vectors representing real input values to be applied to a simulation model of the integrated circuit in Step 160. This representation may be translated into a form which is better suited to simulation. This representation of the integrated circuit is then operated upon by the simulator which produces numerical outputs analogous to the response of a real circuit with the same inputs applied in Step 165. By viewing the simulation results, the user may then determine in Step 170 if the represented circuit will perform correctly when it is constructed If not, she may re-edit the schematic of the integrated circuit, re-compile it and re-simulate it in Step 150. This process is performed iteratively until the user is satisfied that the design of the integrated circuit is correct

Then, the human IC designer may present as input to a logic synthesis tool 175 a cell library 180 and a behavioral circuit model. The behavioral circuit model is typically a file in memory which looks very similar to a computer program, and the model contains instructions which logically define the operation of the integrated circuit. The logic synthesis tool 175 maps the instructions from the behavioral circuit model to one or more logic cells from the library 180 to transform the behavioral circuit model to a gate schematic net list 185 of interconnected cells in Step 187 The gate schematic net list 185 is a database having interconnected logic cells which perform a logical function in accordance with the behavioral circuit model instructions. Once the gate schematic net list 185 is formed, it is provided to a place and route tool 205 to begin the second phase of the design process, physical synthesis.

The place and route tool 205 is preferably then used to access the gate schematic net list 185 and the library cells 180 to position the cells of the gate schematic net list 185 in a two-dimensional format within a surface area of an integrated circuit die perimeter This process is optimized as will be explained in greater detail below. The output of the place and route step may be a two-dimensional physical design file 210 which indicates the layout interconnection and twodimensional IC physical arrangements of all gates/cells within the gate schematic net list 185. From this, in Step 215 the design automation software can create a set of photographic masks 220 to be used in the manufacture of the IC.

One common goal in chip design involves timing perfordesign problems exist In many cases, the IC designer 50 mance The timing performance of the chip is determined by the time required for signals to propagate from one register to another Clock signals driven at a certain frequency control storage of data in the registers. The time required for a signal to propagate from one register to another depends on the number of levels of cells through which the signal has to propagate, the delay through each of the cells and the delay through the wires connecting these cells. The logic synthesis phase 100 influences the number of levels and the propagation delay through each cell because in it the appropriate components are selected, while the physical synthesis 200 phase affects the propagation delay through the wires.

> During the process of timing optimization during physical design in Step 205, circuit timing is evaluated based on an initial placement and selection of cell strengths. The feedback from the timing analysis is used to drive repeated improvements to the placement software and the selection of the strengths of the cells. The automation software may also

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perform buffering on some parts of the circuit to optimize the timing performance by inserting repeater cells, i.e., buffers, to speed up certain paths. See, for example, U.S. patent application Ser. No. 09/300,557 to Buch et al., now U.S. Pat. No. 6,553,338. Preferably, the optimization software tentatively applies one such modification, evaluates the timing and other constraints (such as design rules dictating capacitance limits) to determine if the step is acceptable and then makes the change permanent if it is deemed acceptable

The number of changes to the circuit in terms of change 10 in placement and net list can be numerous during the automatic optimization step 205. In order to evaluate the timing performance and capacitance the automation software needs to construct some reasonable topologies for connecting the nets so that it can make estimates of net 15 capacitances and, from these, timing estimates A complete routing of all the wires at this stage is very time consuming and impractical As an alternative, Steiner tree topologies may be used successfully to estimate delays based on placement. However, constructing a Steiner tree also 20 requires an algorithm with quadratic complexity which makes the optimization process very slow and impractical for a large circuit While it is important to have accurate estimates of the capacitance and delays during the placement and net list optimization step 205, it is also important to be 25 able to compute the delays and capacitance as quickly as possible Computing the capacitance of a net takes at least linear time as a function of the number of pins in the net-Therefore a linear time algorithm to compute the capacitance is desirable

SUMMARY OF THE INVENTION

The present invention has been made in view of the above-described problems of the art, and it is an object of the present invention to provide a fast method of estimating capacitances and wire delays in an integrated circuit design based on placement information such as that contained in a gate schematic net list from a logic synthesis tool. A simple tree topology called a spine tree is constructed to connect the pins of the net as an approximation of actual connections therein Capacitance is extracted for this topology assuming a worst case scenario, and Elmore delays are computed for the wire delays based on the worst-case capacitances. The method takes linear time as a function of the number of pins in the net and is much faster than using a Steiner tree method in this context

BRIEF DESCRIPTION OF THE DRAWINGS

These and other objects, features and advantages of the 50 present invention are better understood by reading the following detailed description of the preferred embodiment, taken in conjunction with the accompanying drawings, in which:

- FIG. 1 is a flowchart of an integrated circuit design ⁵⁵ process according to the prior art;
- FIG 2 is a flowchart of an integrated circuit design process according to a preferred embodiment of the present invention;
- FIG. 3 shows an example circuit having large custom blocks and rows of standard cells for use with the preferred embodiment;
- FIGS 4 and 5 show elements of a spinal network in the preferred embodiment;
- FIG 6 shows an algorithm used in constructing the spinal network in the preferred embodiment;

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FIGS 7A-7H show a step-by-step process of developing a spinal network in the preferred embodiment; and

FIG. ${\bf 8}$ shows a complete spinal network in the preferred embodiment

DETAILED DESCRIPTION OF PRESENTLY PREFERRED EXEMPLARY EMBODIMENTS

Returning to the automated IC design process described above, a preferred embodiment of the present invention is preferably incorporated as part of a place and route tool 1205 as shown in FIG 2 FIG 3 shows a circuit 300 with large blocks 305 and rows 310 of standard logic cells 315 which might be produced by the place and route tool 1205 as is known in the art. In the preferred embodiment, the place and route tool 1205 preserably optimizes timing of the circuit 300 by choosing the placement of the blocks 305 such that the delay across the interconnect wires 320 between cells 315 is minimized and the cells strengths are sufficient to guarantee the required timing performance. The optimization adds repeaters or buffers to selected wires to speed up certain paths. Preferably, placement of the cells, selection of the strengths and insertion of buffers are done in a single optimization process to evaluate the best possible solution

The place and route tool 1205 then preferably operates as a router to determine the placement of interconnect wires 320 connecting the appropriate signals within the circuit boundary and between the various cells 315. Using the net list thus obtained (which maybe different from the original net list due to insertion of buffers or repeaters) and the placement and routing generated as described above, as noted above the design automation software develops a mask layout 220 to finally fabricate the circuit. The net list thus obtained can also be used by other automation software to verify the functionality of the circuit by comparing it with the original net list that has been certified to perform the required functionality.

The present invention may be used to evaluate the wire delays and capacitances quickly during the process of optimizing the placement, selection of cell strengths and insertion of buffers. Every change in the placement changes the position of the pins and hence needs the capacitance and delays to be re-evaluated. When a buffer is inserted, a new net is created and the original net is changed, thus causing two nets to be evaluated. Similarly, when the size of a cell is changed to a different strength, the new cell may have a different shape and area which will cause the pin positions to change, requiring recalculation of the nets connected to all the pins of the cell.

The present invention can be used to recompute the capacitance and wire delays quickly during this optimization process.

As described above, for optimization purposes it is useful to quickly estimate wire delay times. For this purpose, it is useful to quickly estimate interconnect wire capacitances. In order to compute the capacitance and delay of interconnect wires 320, the positions of the pins 325 of a net 330 in the placed design are used to draw a bounding rectangle 335 for the net 330 as shown in FIG. 4. As is known in the art, pins are the points in the layout of a predesigned standard block or a custom block where a wire can be physically connected to hook it up into the signal net. Preferably, the pins are positioned on the boundaries of the block.

This bounding rectangle 335 is the smallest rectangle which encloses all the pins 325 of the net 330 and that lies within the boundary of the chip The main purpose of the bounding rectangle 335 is to determine whether the pins 325

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are generally laid out in a horizontal or vertical direction. thereby enabling an efficient arrangement for the spine

Preferably and with reference to FIG 4, borders of the bounding rectangle are determined by identifying which of the pins 325 is the leftmost (using the drawing page as a 5 frame of reference); which of the pins 325 is the rightmost; which of the pins 325 is uppermost; and which of the pins 325 is lowermost. Sides of the bounding rectangle are then defined by horizontal lines passing through the uppermost and lowermost pins (in the case of FIG. 4, pins 325E and 10 325C, respectively) and vertical lines passing through the rightmost and left most pins (here, pins 325B and 325H)

The shape of the bounding rectangle 335 is used to determine the direction of the "spine" of the net 330 For example, the rectangle in FIG. 4 is longer in the horizontal 15 described above direction; hence, the spine 340 for this net 330 will be horizontal

Once the direction of the spine 340 is determined, its location within the bounding rectangle 335 is determined by taking the average of one of the Cartesian coordinates of all 20 pins 325. If the spine 340 has been determined to be horizontal, the average of the y-coordinates of the pins 325 is taken; if the spine 340 has been determined to be vertical, the average of the x-coordinates of the pins 325 is taken

Consider the bounding rectangle 335 and pins 325 within 25 net 330 of FIG. 4. Suppose the bounding rectangle 335 is mapped onto a 25×15 Cartesian grid so that the coordinates of the pins 325 are as follows, moving from left to right:

325A: (0, 13.75)	325E: (14.375, 15)
325B: (3.75, 6 25)	325F: (16.875, 7.5)
325C: (10, 0)	325G: (21 875, 3.125)
325D: (11.875, 1.875)	325H: (25, 9 375)

Then, averaging the y-coordinates we find that the spine 340 is at y=71—slightly below the middle of the bounding rectangle 335

FIG 5 shows this horizontal spine 340 Once the spine 40 340 is constructed, all the pins 325 are connected to it using the algorithm 400 shown in FIG. 6. First, the pin 325 closest to the spine tree 345 (see FIG 8), i.e., the spine 340 and all connections from it to pins 325, is identified in Step 405 II this pin 325 μ lies on the spine tree 345 in Step 410, it is marked as processed in Step 415 and execution continues as described below. If not, Step 420 connects the pin 325 to the nearest point on the spine tree 345 and the pin 325 is marked as processed in Step 415. If Step 425 determines that there are any unprocessed pins 325 left, execution returns to Step 50 405; otherwise, the spine tree 345 for this net 330 has been developed and may be used for capacitance and delay estimates as described above

FIGS 7A-7H show the step-by-step process of building shown in FIG. 6

FIG. 8 shows the final spine tree 345 constructed for the set of pins 325. The capacitance for the spine tree 345 may be computed by adding the capacitance of each segment thereof together. The capacitance for each segment is calculated using the parasitic extraction rules which are measured from the fabrication process. These rules are expressed in terms of the capacitance due to the overlap in the vertical direction with other layers of metal (i.e., area capacitance)

and the overlap with other wires in the same layer (i.e., lateral capacitance) In order to be conservative in the estimates a worst-case scenario is adopted where it is

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assumed that there is a wire on both sides of the wire with

minimum allowable distance between them

The delays are computed using the Elmore delay formula based on the spine topology. This technique is known in the art and explained in great detail in Elmore, "The Transient Response of a Damped Linear Network with Particular Regard to Wideband Amplifiers", J. Applied Physics, 19:55-63 (1948) (incorporated herein by reference), and for simplicity and brevity will not be described further here. These delays may then be used for calculating estimates in optimizing the placement and routing of the cells as

The present invention has been described above in connection with a preferred embodiment thereof, however, this has been done for purposes of illustration only, and the invention is not so limited Indeed, variations of the invention will be readily apparent to those skilled in the art and also fall within the scope of the invention.

What is claimed is:

1. A method of estimating capacitance of interconnection wires in an integrated circuit design comprising:

determining a rectangle bounding a group of pins whose capacitance is to be estimated;

determining a direction of a spine for connecting the pins based on the bounding rectangle;

connecting the pins to the spine to minimize a total length of the spine and connections, thereby forming a spine tree: and

using the spine tree as a parameter for estimating a capacitance of the interconnection wires

- 2. The method according to claim 1 wherein the step of determining a direction of the spine also determines a location of the spine with the bounding rectangle
- 3. The method according to claim 1 wherein the step of using the spine tree as a parameter for estimating the capacitance of the interconnection wires adds together capacitances of each different segment that make up the spine tree
- 4. The method according to claim 3 wherein the capacitance for each segment is calculated using parasitic extraction rules.
- 5. The method according to claim 4 wherein the parasitic extraction rules adopt a worst case scenario of wire overlap
- 6 The method according to claim 1 further including the step of calculating wire delays.
- 7 The method according to claim 6 wherein the step of calculating wire delays uses an Elmore delay formula based on a topology of the spine tree
- 8. The method according to claim 7 wherein the step of using the spine tree as a parameter for estimating the the spine tree 345 for net 330 according to the algorithm 55 capacitance of the interconnection wires adds together capacitances of each different segment that make up the spine tree
 - 9 The method according to claim 8 wherein the capacitance for each segment is calculated using parasitic extraction rules
 - 10. The method according to claim 9 wherein the parasitic extraction rules adopt a worst case scenario of wire overlap